**Electronics assembly technology - Part 3: Selection** guidance of environmental and endurance test methods Tis a previous seneral de de l'ille for solder joints



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Euroopa standardi EN 62137-3:2012 ingliskeelset	consists of the English text of the European standard
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### EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

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English version

# Electronics assembly technology Part 3: Selection guidance of environmental and endurance test methods for solder joints

(IEC 62137-3:2011)

Techniques d'assemblage des composants électroniques -Partie 3: Guide de choix des méthodes d'essai d'environnement et d'endurance des joints brasés (CEI 62137-3:2011) Montageverfahren für elektronische Baugruppen -Teil 3: Leitfaden für die Auswahl von Umwelt- und (Lebens)dauerprüfungen für Lötverbindungen (IEC 62137-3:2011)

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### **Foreword**

The text of document 91/986/FDIS, future edition 1 of IEC 62137-3, prepared by IEC/TC 91 "Electronics assembly technology" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62137-3:2012.

The following dates are fixed:

latest date by which the document has	(dop)	2012-09-13
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### **Endorsement notice**

The text of the International Standard IEC 62137-3:2011 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60068-1:1988 + A1:1992	NOTE	Harmonized as EN 60068-1:1994 (not modified).
IEC 60068-2-2	NOTE	Harmonized as EN 60068-2-2.
IEC 60068-2-14	NOTE	Harmonized as EN 60068-2-14.
IEC 60068-2-78	NOTE	Harmonized as EN 60068-2-78.
IEC 61760-1	NOTE	Harmonized as EN 61760-1.
IEC 62137:2004	NOTE	Harmonized as EN 62137:2004 (not modified).

# Annex ZA (normative)

# Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60194	3	Printed board design, manufacture and assembly - Terms and definitions	EN 60194	-
IEC 61188-5	Series	Printed boards and printed board assemblies Design and use - Part 5: Attachment (land/joint) considerations		Series
IEC 61249-2-7	-	Materials for printed boards and other interconnecting structures - Part 2-7: Reinforced base materials, clad and unclad - Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad		-
IEC 62137-1-1	2007	Surface mounting technology - Environmenta and endurance test methods for surface mount solder joint - Part 1-1: Pull strength test	I EN 62137-1-1	2007
IEC 62137-1-2	2007	Surface-mounting technology - Environmenta and endurance test methods for surface mount solder joint - Part 1-2: Shear strength test	I EN 62137-1-2	2007
IEC 62137-1-3	2008	Surface mounting technology - Environmenta and endurance test methods for surface mount solder joint - Part 1-3: Cyclic drop test	l EN 62137-1-3	2009
IEC 62137-1-4	2009	Surface mounting technology - Environmenta and endurance test methods for surface mount solder joint - Part 1-4: Cyclic bending test	I EN 62137-1-4	2009
IEC 62137-1-5	2009	Surface mounting technology - Environmental and endurance test methods for surface mount solder joint - Part 1-5: Mechanical shear fatigue test	I EN 62137-1-5	2009
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### **ELECTRONICS ASSEMBLY TECHNOLOGY -**

## Part 3: Selection guidance of environmental and endurance test methods for solder joints

### 1 Scope

This part of IEC 62137 describes the selection methodology of an appropriate test method for a reliability test for solder joints of various shapes and types of surface mount devices (SMD), array type devices and leaded devices, and lead insertion type devices using various types of solder material alloys.

#### 2 Normative references

The following referenced documents are indispensable for the application of this document. For a dated reference, only the edition cited applies. For an undated reference, the latest edition of the referenced document (including any amendment) applies.

IEC 60194, Printed board design, manufacture and assembly – Terms and definitions

IEC 61188-5 (all parts), Printed boards and printed board assemblies - Design and use

IEC 61249-2-7, Materials for printed boards and other interconnecting structures – Part 2-7: Reinforced base materials clad and unclad – Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad

IEC 62137-1-1:2007, Surface mounting technology – Environmental and endurance test methods for surface mount solder joint – Part 1-1: Pull strength test

IEC 62137-1-2:2007, Surface mounting technology – Environmental and endurance test methods for surface mount solder joint – Part 1-2: Shear strength test

IEC 62137-1-3:2008, Surface mounting technology – Environmental and endurance test methods for surface mount solder joint – Part 1-3: Cyclic drop test

IEC 62137-1-4:2009, Surface mounting technology – Environmental and endurance test methods for surface mount solder joint – Part 1-4: Cyclic bending test

IEC 62137-1-5:2009, Surface mounting technology – Environmental and endurance test methods for surface mount solder joints – Part 1-5: Mechanical shear fatigue test

### 3 Terms and definitions

For the purposes of this document, the terms and definitions in IEC 60194, as well as the following, apply.

#### 3.1

#### pull strength for SMD

maximum force to break the joint of a lead to substrate when a gull-wing lead of a surface mount device is pulled using a pulling tool at an angle of 45° to the substrate surface

[IEC 62137-1-1:2007, modified]